### MASTER OF SCIENCE THESIS

Exploration of Non-MPB PZT Compositions for High Piezoelectric Voltage Sensitive 0-3 Composites

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### **Exploration of Non-MPB PZT Compositions for High Piezoelectric Voltage Sensitive 0-3 Composites**

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# **Abstract**

<span id="page-6-0"></span>Piezoelectric composites provide an opportunity to make robust piezoelectric sensors. These materials are based on piezoelectric ceramic powders or particles, which are dispersed in a polymer matrix. In most cases, piezoelectric composites use the same ceramic compositions as the ones used in piezoelectric ceramics. These compositions consist of lead zirconium titanate (PZT) with a composition close to the morphotropic phase boundary (MPB). This research work focuses on exploring the performance of non-MPB compositions of PZT ceramic particles in order to obtain high voltage sensitive 0-3 PZT-Epoxy composites.

The PZT ceramic compositions (PbNb<sub>0.01</sub>[Zr<sub>x</sub>Ti<sub>(1-x)</sub>]O<sub>3</sub>), ranging from pure tetragonal lead titanate (x=0) to rhombohedral (x=0.80) were prepared using the mixed oxide method. These ceramic particles were characterized using XRD, SEM and particle size analyser and were used to prepare both sintered ceramics and 0-3 PZT-epoxy composites. The effect of the ceramic filler composition on the dielectric and piezoelectric properties of the PZT-Epoxy composites was investigated. Unlike PZT ceramics, the best piezoelectric properties were not observed in the MPB-based composites but in the pure tetragonal phase. It was observed that the dielectric constant of the ceramic particles had minimal influence on the effective dielectric constant  $(\epsilon_{r})$  and the piezoelectric charge constant  $(d_{33})$  of the piezoelectric composite due to the depolarization effect of the high dielectric filler materials. The experimentally determined values of the dielectric and piezoelectric properties of the piezoelectric composites were validated using analytical models. The influence of electric fatigue on the polarization of the  $PbTiO<sub>3</sub>$  (PT) and morphotropic phase boundary (MPB) based composites were also examined.

Finally, a material selection criterion was proposed in order to develop piezoelectric composites with high voltage sensitivity. This general material selection criterion is not limited to PZT based ceramics but is also applicable to lead-free ceramic filler materials. Thus, the current research work paves the way for the development of environmental friendly lead-free piezoelectric composites devices with enhanced sensory properties.

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# <span id="page-20-0"></span>**1. An Overview of Piezoelectric Ceramics and Composites**

#### <span id="page-20-1"></span>**1.1 Introduction**

The term 'piezoelectricity' is derived from an ancient Greek work *piezein*, which means to 'squeeze' or 'press'. The piezoelectric effect was discovered by Pierre Curie and Jacques Curie in 1880, when they observed that crystals of tourmaline, quartz, topaz and Rochelle salt generated electrical polarization, when stressed in particular directions. The amount of charges produced was found to be proportional to the pressure applied and these charges got diminished on withdrawal of the pressure

Piezoelectric materials are considered as an important member of the Smart Materials Age due to its ability to produce electrical energy from mechanical energy. This unique property enables the piezoelectric materials to be for sensing applications such as pressure sensors, force sensors and accelerometers. In addition, these piezoelectric materials can also be used as actuators, during which they respond to an applied voltage, resulting in a mechanical strain and cause the 'smart' structure, in which they are embedded, to undergo deformation. The same technique can also be used to control and suppress vibration. Hence it can be seen, if properly designed, the same piezoelectric material can be used as an actuator or sensor within a structure and thus is expected to be an integral part of the 'smart' systems, which have a variety of potential aerospace applications such as active vibration control, energy harvesting and structural health monitoring.

In this chapter, the general characteristics of piezoelectric materials are reviewed. A brief introduction to the macroscopic and microscopic aspects of piezoelectric materials is provided initially, which confirms the phenomenon of piezoelectricity. Later on, a general review on the constitute equations and coefficients of piezoelectric effect, along with a brief outlook on different types of piezoelectric materials and its applications, are given. The chapter concludes by providing an overview regarding the motivation behind this research work and its main objectives.

### <span id="page-21-0"></span>**1.2 Piezoelectric Effect**

The piezoelectric effect is a linear electromechanical interaction between the mechanical and electrical state in crystal without a center of symmetry and is reversible in nature [\[1\]](#page-74-1). This piezoelectric behaviour can be classified into two – *direct piezoelectric effect* and *indirect piezoelectric effect*.

#### <span id="page-21-1"></span>**1.2.1 Direct Effect**

When a mechanical load is applied on a piezoelectric material, electric charges are generated on the surface of the material, resulting in the formation of an electric field. This effect is known as *direct piezoelectric effect* [\[1\]](#page-74-1) and is shown in Fig. 1.1. This electric field generated can be tapped as electric voltage by the application of electrodes on both sides, which are normal to the direction of the applied mechanical load, of the piezoelectric materials. This mode of application of piezoelectric material enables it to be used for sensory applications such as energy harvesters [\[2\]](#page-74-2) and pressure sensors [\[3\]](#page-74-3).



**Fig. 1.1: Direct Piezoelectric Effect [\[4\]](#page-74-4)**

#### <span id="page-21-3"></span><span id="page-21-2"></span>**1.2.2 Inverse Effect**

Converse to the direct piezoelectric effect, when an electric field is applied on a piezoelectric material, it gets deformed. This effect is known as inverse or converse piezoelectric effect and is shown in Fig. 1.2. This mode of piezoelectric effect enables the piezoelectric material to act as actuators and have potential applications in the field of adaptive or morphing structures. In addition, from Fig. 1.2(c) it can be seen that by the application of an AC voltage, it is possible to expand and contact the piezoelectric material alternatively.

<span id="page-21-4"></span>

**Fig. 1.2: Inverse Piezoelectric Effect [\[4\]](#page-74-4)**

#### <span id="page-22-0"></span>**1.2.3 Origin of Piezoelectricity**

The origin of piezoelectric effect is attributed towards the asymmetry in the unit cell and the resultant generation of electric dipoles due to the mechanical distortion leading to a net polarization at the crystal surface. Fig. 1.3 shows the typical perovskite crystal structure, for example barium titanate (BaTiO<sub>3</sub>). Above a critical temperature, known as the *Curie temperature*  $(T_c)$ , the crystal structure is cubic, as shown in Fig. 1.3(a), with  $A^{2+}$  ions at the cube corners, O<sup>2-</sup> at the face centres and B<sup>4+</sup> ions at the body centre. Below the *Curie temperature,* the location of the  $B^{4+}$  cation does not coincide with the oxygen octahedron, leading to a permanent electric dipole, as shown in Fig. 1.3(b).



**Fig. 1.3: The perovskite crystal structure [\[5\]](#page-74-5)**

<span id="page-22-1"></span>Apart from above mentioned single crystal materials, there also exists an important class of piezoelectric materials known as ferroelectric ceramics, which are synthesized by sintering of metal oxides such as the lead zirconate titanate (PZT), bismuth sodium titanate (BNT) and . These ferroelectric ceramics can be considered as a collection of single crystals and globally this type of material do no possess any piezoelectric properties due to the randomly oriented ferroelectric domains within the ceramics before poling, as shown in Fig. 1.4(a) [\[5\]](#page-74-5).



<span id="page-22-2"></span>**Fig. 1.4: Schematic illustration of the Poling process [\[6\]](#page-74-6)**

During the poling process, a strong external DC electric field is applied on the piezoelectric material in order to reorient the domains in the direction of the applied electric field. But it should be noted that all the domains will not become exactly aligned on the application of the external field and some of the domains gets aligned only partially whereas some do not align at all (Fig. 1.4(b)). The reason behind this can be attributed to the presence of intergranular stresses, which tends to keep the polarity of the domains in their initial position itself, thereby preventing the switching of the domains to it most favourable direction (i.e. direction of applied field). In addition, the crystal imperfections could also account towards the strain within the grain, which in turn also prevents the reorientation of dipoles. After the removal of the electric field, a *remnant polarization* (Pr) and *remnant strain* remains in the material, which results in the piezoelectricity (Fig. 1.4(c)) [\[1,](#page-74-1) [7\]](#page-74-7).

#### <span id="page-23-0"></span>**1.3 Piezoelectric Constitutive Equations**

The constitutive equations describe the piezoelectric effect based on the coupling of the mechanical and electrical behaviour of the piezoelectric material, i.e., total strain in the piezoelectric material is the sum of mechanical strain induced by the mechanical stress and the actuation strain caused by the applied electric voltage. The electromechanical equations for a linear piezoelectric material used for actuator (Eq. 1.1 and 1.2) and sensor (Eq. 1.3 and 1.4) applications can be written as [\[8,](#page-74-8) [9\]](#page-74-9):

$$
\epsilon_i = S_{ij}^E \sigma_j + \mathbf{d}_{mi} E_m \tag{1.1}
$$

$$
D_m = \mathbf{d}_{mi}\sigma_i + \xi_{ik}^{\sigma}E_k \tag{1.2}
$$

$$
\varepsilon_{i} = S_{ij}^{D} \sigma_{j} + g_{mi} D_{m}
$$
 (1.3)

$$
E_i = g_{mi}\sigma_i + \beta_{ik}^{\sigma}D_k \tag{1.4}
$$

where  $\sigma$  is stress vector [N/m<sup>2</sup>],  $\varepsilon$  is strain vector,  $E$  is the vector of applied electric field [V/m], is permittivity [F/m], *d* is the matrix of piezoelectric charge constants [C/N], *S* is the matrix of compliance coefficients [m<sup>2</sup>/N], D is the vector of electric displacement [C/m<sup>2</sup>], g is the matrix of piezoelectric voltage constants [V.m/N = m<sup>2</sup>/C] and  $\beta$  is the impermitivity component (m/F). In addition, the superscripts *D*, *E* and *σ* represent measurements taken at constant electric displacement, constant electric field and constant stress respectively and the indexes *i, j* = 1, 2, . . . , 6 and *m, k* = 1, 2, 3 refer to different directions within the material coordinate systems, as shown in Fig. 1.5.



**Fig. 1.5: Axis nomenclature[\[5\]](#page-74-5)**

#### <span id="page-24-3"></span><span id="page-24-0"></span>**1.4 Piezoelectric Coefficients**

The physical meaning of various piezoelectric coefficients – *Dielectric Coefficient (εij), Piezoelectric Charge Constant (dij), Piezoelectric Voltage Constant (gij)* and *Piezoelectric Coupling Coefficients (k)* will be discussed in this section. These coefficients play an important role in the performance of the piezoelectric materials [\[8,](#page-74-8) [10,](#page-74-10) [11\]](#page-74-11).

#### <span id="page-24-1"></span>**1.4.1 Dielectric Coefficient (εij)**

Dielectric coefficient  $(\epsilon_{ii})$  determines the charge per unit area in the *i*-axis due to an electric field applied in the j-axis. The relative dielectric constant  $(\epsilon_{r})$  of a piezoelectric material with capacitance *C*, thickness *d* and electroded area *A* is given as [\[12\]](#page-74-12):

$$
\varepsilon_r = \frac{C \, \mathrm{A}}{d \varepsilon_0} \tag{1.5}
$$

where  $\epsilon_0$  is the permittivity of free space = 8.854 x 10<sup>-12</sup> F/m

#### <span id="page-24-2"></span>**1.4.2 Piezoelectric Charge Coefficient (dij)**

Piezoelectric charge coefficient is defined as the polarization generated per unit mechanical stress applied to a piezoelectric material (i.e. direct piezoelectric effect) or the mechanical strain experienced by a piezoelectric material per unit of applied electric field (i.e. converse piezoelectric effect) [\[13\]](#page-74-13). In case of actuator application,  $d_{ii}$  indicates the magnitude of the deformation in the i-direction due to an electric field applied in j-direction (*m/V*) whereas in the case of sensor applications, the subscripts indicate the polarization generated along idirection due to an applied stress in j-direction. The piezoelectric charge constant is an important role in the pressure sensors, force sensors and actuator applications.

#### <span id="page-25-0"></span>**1.4.3 Piezoelectric Voltage Coefficient (gij)**

Piezoelectric voltage constant  $(g_{ii})$  is defined as the electric field generated along the jdirection for unit stress applied in i-direction. The piezoelectric voltage coefficient is an important parameter for energy harvesting applications. The relation between  $\varepsilon_{ii}$ , d<sub>ij</sub> and  $g_{ii}$  is given by Eq. 1.6. From this relation it can be seen that for voltage sensitive application, a piezoelectric material with low  $\varepsilon_{ii}$  and relatively higher d<sub>33</sub> is preferred.

$$
g_{33} = \frac{d_{33}}{\varepsilon_r \varepsilon_0} \tag{1.6}
$$

#### <span id="page-25-1"></span>**1.4.4 Piezoelectric Coupling Coefficients (k)**

Piezoelectric coupling coefficients represent the ability of a piezoelectric material to transform electrical energy to mechanical energy and vice versa and is given as follows [\[13\]](#page-74-13):

$$
k^{2} = \frac{Stored \text{ mechanical energy}}{Input \text{ electrical energy}} = \frac{Stored \text{ electrical energy}}{Input \text{ mechanical energy}}
$$
(1.7)

#### <span id="page-25-2"></span>**1.5 Piezoelectric Materials**

A wide range of natural and man-made materials exhibit the phenomenon of piezoelectric effect and these materials can be as – *single crystal materials* [\[14,](#page-74-14) [15\]](#page-74-15), *piezoelectric ceramics* [\[1\]](#page-74-1), *piezoelectric polymers* [\[16\]](#page-74-16), *piezoelectric-composites* [\[11,](#page-74-11) [17\]](#page-74-17) and *piezoelectric thin films* [\[18,](#page-74-18) [19\]](#page-75-0). Among the various types of piezoelectric materials, piezoelectric ceramics and piezoelectric composites will be explained in detail in the following sections of this chapter.

#### <span id="page-25-3"></span>**1.5.1 Piezoelectric Ceramics**

Among the various types of piezoelectric ceramics [\[1\]](#page-74-1), Lead Zirconate Titanate (PZT ) based ceramics is the most widely known and used piezoelectric material [\[20,](#page-75-1) [21\]](#page-75-2). PZT has a perovskite structure, as shown in Fig. 1.3. As mentioned in Section 1.2.3, the sintered PZT ceramics lack piezoelectric behaviour on a macroscopic scale due to the random orientation of the domains. Hence it is necessary to pole these PZT ceramics, in order to orient the domains in a particular direction by the application of a strong external electric field (in the order 1 to 4 kV/mm) at an elevated temperature. The dielectric and piezoelectric properties of different types of piezoelectric ceramics have been compiled and tabulated in Table 1.1 below. Since quartz and PVDF are also used as piezoelectric sensors, the dielectric and piezoelectric properties of these materials were also added to the table below.

<span id="page-26-0"></span>

	$T_c$		$d_{33}$	<b>g</b> <sub>33</sub>	Reference	
<b>Material</b>	(°C)	$\pmb{\varepsilon}_\text{r}$	(pC/N)	(mV.m/N)		
BaTiO <sub>3</sub>	115	1900	191	11	$[1]$	
BaTiO <sub>3</sub> -CaTiO <sub>3</sub> -Co	105	1420	150	12	[22, 23]	
$(K_{0.5}Na_{0.5})NbO3$	420	290	80	31	$[24]$	
KNN-LiTa $O_3$ (5%)	430	570	200	40	$[25]$	
$KNN-SrTiO3(5%)$	277	950	200	24	$[20]$	
LiNbO <sub>3</sub>	1415	29	6	23	$[26]$	
NBT-KBT-LBT	350	1150	216	21	$[20]$	
PbNb <sub>2</sub> O <sub>6</sub>	300	225	85	43	$[27]$	
PbTiO <sub>3</sub>	490	200	50	28	$[28]$	
PLFZT <sup>#</sup>	548	1266	93	9	$[29]$	
PZT-4	325	1300	289	25	$[27]$	
PZT5A	350	1700	374	25	$[27]$	
PZT-5H	195	3400	593	20	$[27]$	
<b>PZT 507</b>	165	4400	820	21	$[30]$	
<b>PVDF</b>	195	13	$-33$	$-287$	$[31]$	
Quartz	573	4.51	2.31	58	[32, 33]	

**Table 1.1: Dielectric and piezoelectric properties of ceramics at room temperature**

 $*_{g_{33}}$  is calculated using Eq. 1.6; KNN:  $(K_{0.5}Na_{0.5})NbO_3$ ; NBT:  $(Na_{0.5}Bi_{0.5})TiO_3$ ; KBT:  $(K_{0.5}BiO.5)TiO_3$ ; LBT:  $(Li_{0.5}Bi_{0.5})TiO_3$ ; #PLFZT: Fe-doped  $[(PbLa)(Zr-Ti)O_3]$ ; [\[26\]](#page-75-7)

The dielectric and piezoelectric properties of PZT ceramics were found to be enhanced in the phase transition region, known as morphotropic phase boundary (MPB), where a significant variation in polarization was observed. This compositionally-induced phase transition of PZT solid solution at a Zr/Ti ratio of 52/48 results in an enhanced dielectric and piezoelectric properties, which is nearly independent over a wide range of temperature [\[34\]](#page-75-15). In PZT ceramics, the enhanced properties occurs in the region of the composition-temperature phase diagram where crystal structure changes from tetragonal to rhombohedral via an intermediate monoclinic phase as the Zr/Ti ratio becomes close to 52/48 (see Fig. 1.6) [\[1,](#page-74-1) [35\]](#page-75-16). The significance of this MPB is so intense that search for new piezoelectric materials (such as leadfree [\[34\]](#page-75-15) and piezoelectric composites [\[11\]](#page-74-11)) are naturally focused on those exhibiting similar MPB transition, expecting dominant dielectric and piezoelectric properties [\[36\]](#page-75-17).



<span id="page-27-1"></span>In addition to compositional modification mentioned above, the chemical modification of PZT ceramics by doping can also greatly enhance the properties of the ceramics. The process of doping involves modifying the properties of PZT ceramics by the addition of small amount of impurities. Depending on the type of impurity added, the PZT ceramics is classified as '*Hard*' and '*Soft*' ceramics. In soft PZT ceramics, few of the  $A^{2+}$  and/or  $B^{4+}$  sites in the perovskite crystal structure (see Figure 1.3) are replaced by three valent and/or five valent cations, such as La<sup>3+</sup> and  $Nb<sup>5+</sup>$  (i.e. donor doping), respectively, resulting in the formation of cationic vacancies at the A and/or B sites. Due to the presence of cationic vacancies, the domain walls move easily, resulting in lower coercive field. This further makes the poling process of soft PZT much easier and more effective and also leads to better dielectric and piezoelectric properties compared to that of undoped PZT ceramics [\[1,](#page-74-1) [37\]](#page-75-18). On the other hand, the hard PZT ceramics are obtained by replacing few of the  $B^{4+}$  cations by lower valent cations, such as  $Fe^{3+}$  and Ni<sup>2+</sup> (i.e. acceptor doping), resulting in the formation of anionic vacancies within the crystal structure of the PZT ceramic. Due to this, the domain walls get pinned to the oxygen vacancies and consequently, the hard PZT ceramics are difficult to pole and thus show lower piezoelectric properties [\[5,](#page-74-5) [38\]](#page-75-19). However, hard PZT ceramics are preferred in the applications that require high *Curie*  temperature and mechanical quality factor. Since soft PZT ceramics are commonly applied for sensing applications, due to its superior piezoelectric properties compared to that of its counterpart, the PZT ceramics used in this research will be doped with  $\text{Nb}^{5+}$ .

#### <span id="page-27-0"></span>**1.5.2 Piezoelectric Composites**

In spite of the relatively high charge constants  $(d_{33})$  and being excellent candidates for actuator applications, the high dielectric constant of PZT ceramics ( $\varepsilon_r$  = 1800 - 2200) reduces its voltage sensitivity ( $g_{33}$ ) quite drastically. Due to this, PZT ceramics are a poor choice for sensoric applications. In addition, the high density of PZT ceramics ( $\rho$  = 7.9 g/cm<sup>3</sup>) restricts its applications in the field of aerospace engineering. Moreover, PZT is brittle in nature, which makes it difficult to process and shape into required forms. Due to these drawbacks of PZT ceramics, the development of piezoelectric composites have gained a lot of momentum since last three decades as it possess a high coupling factor, low acoustic impedance, moderate dielectric constant and better voltage sensitivity, along with superior mechanical properties and flexibility compared to that of piezoelectric ceramics. The PZT-Polymer composites is a combination of an active piezoelectric phase and a passive polymer phase, which helps in obtaining composites with tailored and unique set of dielectric, piezoelectric and mechanical properties. The presence of passive polymer phase is responsible for providing desired properties to the piezoelectric composite material, such as increasing mechanical robustness, low density and acoustical impedance. In general, a typical two phase piezoelectric composite is classified into 10 types depending on the physical connectivity of each phase [\[39,](#page-76-0) [40\]](#page-76-1), as shown in Fig. 1.7, with the first number denoting the connectivity of active phase and the second number refers to the passive phase. This connectivity pattern between the active and passive phase has high influence on the processing and final properties of the piezoelectric composite prepared [\[41\]](#page-76-2).



<span id="page-28-0"></span>**Fig. 1.7: Overview of the possible connectivity schemes between active ceramic phase (white) and passive polymer phase (grey) of two phase piezoelectric composites [\[40\]](#page-76-1)**

Among these various types of piezoelectric composites, 0-3 and 1-3 type of connectivity have received the most attention. In 1-3 composites, the ceramic phase is fully connected from

electrode to electrode, due to which this type of composites are seen as a direct replacement to bulk ceramics. Unfortunately, the superior properties of 1-3 composites come with high production costs and also suffers from performance degradation after a certain number of loading cycles [\[41,](#page-76-2) [42\]](#page-76-3). As an effort towards the reduction of the production cost associated with 1-3 composites, an interesting technique was developed by which piezoelectric particles/short fibers dispersed in a polymer matrix were made structured by means of dielectrophoresis process, thereby resulting in the formation of quasi 1-3 composites [\[30,](#page-75-11) [43\]](#page-76-4). Alternatively, 0-3 composites is the simplest of all composites and consists of randomly distributed piezoelectric ceramic particles in polymer matrix. Even though 0-3 composites exhibit lower piezoelectric properties compared to that of 1-3 composites [\[40\]](#page-76-1), the former is relatively easy and cheap to manufacture and is thus chosen as the type of composite to be prepared as a part of this research work. A comprehensive overview regarding the various methods for making piezoelectric composites have been presented in the work of *Akdogan et al* [\[11\]](#page-74-11). Table 1.2 shows the dielectric and piezoelectric properties of 0-3 composites with different types of polymer phases.

Composite	$\pmb{\varepsilon}_\text{r}$	$d_{33}$ (pC/N)	<b>g</b> <sub>33</sub> (mV.m/N)	<b>References</b>
0-3 PZT (70%) - Epoxy	100	45	51	$[44]$
0-3 PZT (60%) - Epoxy (Structured)	45	17	43	$[43]$
0-3 PZT (68.5%) – Carbon (1.5%) – Epoxy	120	50	47	$[44]$
0-3 PZT (70%) - PVDF	105	25	27	$[45]$
$0-3$ PZT (50%) – PU	48	30	71	$[46]$
0-3 PZT (70%) - PVDF - Fluorine Elastomer	26	10	43	$[47]$
0-3 PbTiO <sub>3</sub> - Rubber	45	40	100	$[21]$
0-3 PZT (50%) - LCT - PA (20%)	73	42	65	[48]
$0-3$ PZT (50%) – PA	68	28	47	$[48]$
0-3 PZT (40%) - LCT	30	13	49	$[49]$
0-3 PZT (30%) - Zn ionomer	9	5	63	[50]
0-3 PZT (30%) - EMMA	8	$\overline{2}$	28	$[50]$
$BNBT - P(VDF-TrFE)$ (70%)	21	14	75	$[51]$

<span id="page-29-0"></span>**Table 1.2: Overview of the dielectric and piezoelectric properties of different types of 0-3 composites**

\*g33 is calculated using Eq. 1.6; PVDF - Polyvinylidene fluoride; PU – Polyurethane; LCT - Liquid Crystalline Thermoset; PA – Polyamide; EMMA - ethylene methacrylic acid copolymer; BNBT -  $(Bi_{0.5}Na_{0.5})TiO<sub>3</sub>$ -BaTiO<sub>3</sub>; P(VDF-TrFE) - poly[(vinylidenefluoride-co-trifluoroethylene]

#### <span id="page-30-0"></span>**1.6 Motivation and Objectives of the Thesis**



<span id="page-30-1"></span>**Fig. 1.8: Variation of room temperature dielectric constant (εr) with composition for Pb(Ti, Zr)O<sup>3</sup> ceramics (adapted from [\[1\]](#page-74-1))**

Most of the piezo devices are based on piezoelectric ceramics and among this, MPB composition of PZT solid solution are widely accepted for many applications. The reason behind this wide acceptance of MPB composition is the co-existence of rhombohedral and tetragonal phases, which results in an increased ease of domain orientation during poling, resulting in enhanced dielectric and piezoelectric properties. The dielectric and piezoelectric properties of MPB and close to MBP compositions of bulk ceramics have been well researched and documented by *Jaffe et al* [\[1\]](#page-74-1)*.* From Fig. 1.8 and Fig. 1.9, it is noteworthy that the dielectric constant  $(\epsilon_r)$  and piezoelectric charge constant  $(d_{33})$  exhibits their highest values at MPB composition, while the piezoelectric voltage constant  $(g_{33})$  maintains its high values into the rhombohedral field. The main reason which restricts the exploration of PZT phase diagram away from the neighbourhood of MPB is the poor sinterability and the poling difficulty associated with the tetragonal PZT ceramics (explained in detail in Chapter 4) and the antiferroelectric nature of the rhombohedral phase of the PZT ceramics. As far as the sensoric applications of piezoelectric ceramics are considered, the piezoelectric voltage coefficient ( $g_{33}$ ) plays a major role in determining the voltage sensitivity of the ceramics. Even though the high  $d_{33}$  of MPB and close to MPB compositions of ceramics favours higher  $g_{33}$ , the very high  $ε<sub>r</sub>$  of MPB ceramics deteriorates the final voltage sensitivity of PZT ceramics (see Eq. 1.6). Hence, in order to enhance the application of PZT ceramics as voltage sensors, it is necessary to explore the non-MPB compositions of PZT to identify a ceramic composition which would result in a

significantly higher  $g_{33}$  than that of PZT ceramics with MPB or close to MPB compositions. As a result, a systematic research is very much needed to complete the entire phase diagram of PZT (shown in Fig. 1.6) ceramics by preparing bulk ceramics of compositions PbNb $_{0.01}$ (Zr<sub>x</sub>Ti<sub>(1-x)</sub>)O<sub>3</sub>, for x varying from 0 to 0.80.



<span id="page-31-0"></span>**Fig. 1.9: Variation of room temperature piezoelectric charge coefficient (d33) with composition for Pb(Ti, Zr)O<sup>3</sup> ceramics (adapted from [\[1\]](#page-74-1))**



<span id="page-31-1"></span>**Fig. 1.10: Variation of room temperature piezoelectric voltage coefficient (g33) properties with composition for Pb(Ti, Zr)O<sup>3</sup> ceramics (adapted from [\[1\]](#page-74-1))**

Unlike bulk ceramics, in which the ceramic grains are in contact with each other in all direction, in 0-3 piezoelectric-polymer composites, the high  $\varepsilon_r$  PZT ceramic filler particles having a particle size of 2-4  $\mu$ m range are surrounded by a low  $\varepsilon_r$  polymer phase, with no connectivity between the filler particles. Due to this, the piezoelectric composites will exhibit entirely different poling and polarization mechanisms. Consequently, it is not necessary that the MPB or close to MPB compositions of ceramic filler particles will result in higher dielectric and piezoelectric properties. In addition, the presence of polymer phase results in a better poling process of tetragonal compositions of PZT ceramic filler particles compared to that of its bulk ceramic counterparts. Even though the lack of connectivity will result in lower  $d_{33}$ , the significantly lower effective  $\varepsilon_r$  results in an enhanced  $g_{33}$  in composites, which enable these composites to be used for various potential applications such as pressure sensors and strainenergy harvesting. As a result, efforts will be made in this research work in exploring the effect of non-MPB PZT compositions as fillers in 0-3 composites.

Based on the above prospects expected from the 0-3 piezoelectric composites, the following objectives have been formulated which would be investigated during the course of this research work:

- Investigate the possibilities of using non-MPB PZT compositions as the filler materials in 0-3 PZT-Polymer composites in order to maximize the voltage sensitivity ( $g_{33}$ ) of the piezoelectric composites
- study the effect of dielectric constant of ceramic filler on the dielectric and piezoelectric properties of the PZT-Polymer composites prepared
- Inspect the effect of depolarization factor due to the ceramic on piezoelectric charge constant  $(d_{33})$  of 0-3 PZT-Polymer composites
- Propose certain material selection criteria for preparing 0-3 piezoelectric composites with good sensorial properties.

### <span id="page-34-0"></span>**2. Experimental**

### <span id="page-34-1"></span>**2.1 Introduction**

As far as the preparation of 0-3 composite materials are considered, there are several factors, which will have an influence on its final properties such as the dielectric and piezoelectric properties of the constituent materials, poling conditions, filler volume fraction, filler grain size, density, porosity and poling conditions. Thus it is necessary to follow the above factors while preparing the composites in order to have a better repeatability.

In this chapter, the procedure for the preparation of  $PbNb<sub>0.01</sub>[Zr<sub>x</sub>Ti<sub>(1-x)</sub>]O<sub>3</sub>$  ceramic powder, sintered ceramic disks and 0-3 composites are discussed in detail initially. Secondly, various characterization techniques adopted to study the microstructure and dielectric properties of PZT ceramics are given in following sections. Finally, the 0-3 composites prepared were analyzed with respect to their microstructure, P-E hysteresis, dielectric and piezoelectric properties and electric fatigue response.

### <span id="page-34-2"></span>**2.2 Processing of Ceramic Powder and Ceramic Disks**

#### <span id="page-34-3"></span>**2.2.1 Ceramic Powder**



<span id="page-34-4"></span>**Fig. 2.1: Flow chart for the preparation of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> by solid state reaction process**

Among the various techniques available [\[52,](#page-76-13) [53\]](#page-76-14), the most conventional and economical mixed oxide process (also known as solid state reaction process) was used to synthesize the  $PbNb<sub>0.01</sub>[Zr<sub>x</sub>Ti<sub>(0.99-x]</sub>]O<sub>3</sub>$  ceramic powder and Table 2.1 shows the list of ceramic compositions prepared. Henceforth, the compositional codes mentioned in Table 2.1 will be used in the subsequent sections.



<span id="page-35-0"></span>

The lead oxide (PbO), zirconia (ZrO<sub>2</sub>), titania (TiO<sub>2</sub>) and niobium pentoxide (Nb<sub>2</sub>O<sub>5</sub>) from Sigma Aldrich, with 99.9% purity, were used as the raw materials. The raw materials were weighed according to the stoichiometric proportions based on the desired ceramic
composition. In order to attain homogeneity, the raw materials were thoroughly milled with 5 mm zirconium balls for 7 hrs in distilled water. The mixture was then dried using hot air oven in order to evaporate the distilled water. The dried powder was then calcined in a furnace using a closed alumina crucible at 750°C for 2 hrs at a heating rate of 2°C/min in order to initiate the formation of perovskite phase. The calcined powders were crosschecked for phase formation by X-ray diffraction technique. Once the phase formation was observed the powder was milled again as mentioned above for 3 hrs and was dried in a hot air oven for overnight at 120°C. The dried powder was calcined again at 1150°C for 2 hrs at a heating rate of 2°C/min. The flow chart depicting the formation of ceramic powder by solid state reaction is shown in Fig. 2.1. The crystal structure and phase formation of the ceramic powders were determined using X-ray diffraction technique, which will be explained in the Section 2.4.



#### **2.2.2 Ceramic Disks**



In order to investigate the dielectric and piezoelectric properties of ceramics, four to five sintered ceramic disks were prepared by pellet-pressing. Prior to the pressing of ceramic disk, Polyvinyl alcohol (PVA) was used as a binder in order to reduce the brittleness of the disks. The fine and homogeneous ceramic powder was pressed into cylindrical disks of 6.5 mm diameter and 1.5-2.5 mm thickness under an uniaxial pressure of  $5x10^5$  N/m2 using a hydraulic press. The pressed ceramic disks were sintered for 2 hrs at 1250°C on a bed of commerically avaiable PZT powder using a high temperature furnace. From Fig. 2.2, it can be seen that the ceramic disks with high Ti content (resulting in high tetragonality) such as PT and PZT 40 displayed poor sinterability, which made the poling process impossible. The reason behind this poor sinterability will be discussed in detail in Chapter 4.

#### **2.3 Epoxy Thermoset Polymer**

The two component epoxy system used for the preparation of 0-3 composites is a two component – *Epotek 302-3M Epoxy (diglycidyl ether of bisphenol-A) resin* and *poly(oxypropyl) diamine multifunctional aliphatic amine curing agent.* The chemical structure of the resin and curing agent is as shown in Fig. 2.3. The dielectric constant of the cured Epoxy matrix is estimated to be 4.2 and the polymer possesses excellent dimensional stability upto a temperature of 100°C. As a result, the poling temperature of the 0-3 composite prepared using epoxy polymer has been set as 80°C.



**Fig. 2.3: Chemical structure of (a) diglycidyl ether of bisphenol-A resin [\[54\]](#page-76-0) and (b) Poly(oxypropylene) diamine curing agent [\[55\]](#page-77-0)**

### **2.4 Processing of 0-3 PZT–Epoxy Composites**

The 0-3 composites were prepared by tape-casting method by following the steps as shown in the Fig. 2.3. The ceramic filler particles were initially dispersed in the resin component of the epoxy and mixed at 3000 rpm for 5 min using a planetary mixer (SpeedMixer DAC 150.1 FVZ). The slurry thus obtained was degassed for 5 min. Subsequently, the curing agent was

added to the mix of resin and ceramic particles and was mixed at 2000 rpm for 5 min. Finally the composite slurry was degassed for 5 min in order to remove air bubbles. Subsequently, the composite slurry was deposited on a thin aluminium foil and tape-casted using a movable header at a speed of 2 m/s, resulting in the formation of around 200 micron thin sheets of 0-3 PZT Epoxy composites, as shown in Fig.2.4. For each variation of PbNb $_{0.01}$ [Zr<sub>x</sub>Ti<sub>(1-x)</sub>]O<sub>3</sub> ceramic powders synthesized, 20 and 40 vol% of ceramic filler-epoxy composites were prepared. The composites thus formed were cured at room temperature for 24 hrs. After curing, the composites samples were cut into thin circular disks of 12 mm diameter using a circular punch.



0-3 PZT - Epoxy Composite **Fig. 2.4: Flow chart for 0-3 PZT – Epoxy Composite processing**

## **2.5 Phase Analysis and Microstructure Characterization**

### **2.5.1 X-ray Diffraction (XRD)**



**Fig. 2.5: Bruker D8 ADVANCE X-ray Diffractometer**

The phase purity and lattice parameters of the calcined PbNb<sub>0.01</sub>[Zr<sub>x</sub>Ti<sub>(1-x)</sub>]O<sub>3</sub> ceramic powders were examined using X-Ray diffraction. The fine powdered ceramic samples were analysed using Bruker D8 ADVANCE X-ray Diffractometer, shown in Fig.2.5, using Co-Kα radiation of wavelength 1.79 Å. The XRD experiment was carried out at room temperature for a two theta (2θ) from of 5° to 70°, using a step size of 0.02° and a scan step of 1 s. The XRD data obtained were further analysed using PANalytical X'Pert HighScore Plus, Version 2.0, to determine the lattice parameters of each compositions of PbNb $_{0.01}[Zr_xTi_{(1-x)}]O_3$  ceramic powder.

#### **2.5.2 Particle Size Analysis**



**Fig. 2.6: Beckman Coulter LS 230 particle analyser**

The laser diffraction technique was used to determine the particle size distribution of the calcined ceramic powder using Beckman Coulter LS 230 particle analyser (shown in Fig. 2.6) at a laser wavelength of 750 nm at Kramers laboratory of DelftChemTech. Prior to the analysis, the calcined powder was mixed with distilled water and sodium pyrophosphate (dispersion medium). The resulting solution was then ultrasonicated for 5 min in order to free the powder from agglomerates.



## **2.5.3 Scanning Electron Microscopic (SEM) Analysis**

**Fig. 2.7: Scanning Electron Microscopy (SEM) JEOL JSM 840A**

The microstructural analysis of the ceramic powders and the cross sections of ceramic disks and composites were carried out using a scanning electron microscope (JEOL – JSM 840A), shown in Fig. 2.7. The specimens were gold coated prior to being analysed using SEM in order to facilitate imaging, as the specimens are non-conducting.

## **2.6 Poling of 0-3 PZT–Epoxy Composites**

The room temperature cured circular disk-shaped 0-3 PZT-epoxy composite specimens were post-cured at 120°C in order to remove moisture. The gold electrodes of 9 mm were deposited on the Aluminium-free side of post-cured composite specimens using Balzers Union Sputtering System SCD 040. The electroded composite samples were poled at 15 kV/mm at 80°C in silicon oil bath for 1 hr. The samples were then cooled down to 30°C in the presence of poling field and was allowed to age for 24 hrs before measuring the dielectric and piezoelectric properties. Fig. 2.8 shows the set-up used for the poling process.



**Fig. 2.8: Set-up for poling process: (a) High voltage amplifier and (b) Silicon oil bath**

## **2.7 P-E Hysteresis and Polarization Fatigue Measurement**



**Fig. 2.9: Piezoelectric hysteresis and polarization fatigue measurement set-up**

The P-E hysteresis loop measurements were carried out to determine the remnant polarization (P<sub>r</sub>), spontaneous polarization (P<sub>s</sub>) and coercive field (E<sub>c</sub>) of the 0-3 composites prepared. The experiments were carried out at room temperature at an applied field range from 1 to 600 kV/cm, using a standardized ferroelectric measurement test system of Radiant Technology (Version 5.0.3), at Max Planck Institute for Polymer Research at Mainz, Germany. The room temperature polarization fatigue measurements were carried out using Radiant Technology (Version 4.0.5), as shown in Fig. 2.9, at the Physical Lab of Aerospace and Structures Department at Delft.

## **2.8 Measurement of Dielectric and Piezoelectric Properties**



**Fig. 2.10: Berlincourt d<sup>33</sup> meter (a) and LCR meter (b)**

The dielectric constant of the ceramic disks and composites were measured using the parallel plate capacitor method using an Agilent 4263B LCR meter at 1 V and 1 kHz. The piezoelectric charge constant  $(d_{33})$  of the composites were performed using a Berlincourt type  $d_{33}$  meter and the measurements were carried out at a standard static force of 10 N and frequency of 110 Hz. Fig. 2.10 shows the equipment used to measure the dielectric and piezoelectric properties.

# **3. Modelling of Dielectric and Piezoelectric Properties**

## **3.1 Introduction**

Piezoelectric ceramic-polymer composites are being increasingly used for sensor and actuator applications [\[11,](#page-74-0) [56\]](#page-77-1). The piezoelectric composites consists of high dielectric constant ceramic particles embedded (randomly or structured) in a low dielectric polymer matrix, exhibiting good mechanically flexibility, easy formability, low density and low dielectric losses [\[42,](#page-76-1) [57\]](#page-77-2). The major factors which determine the final properties – dielectric and piezoelectric coefficients – of these composites are as follows [\[58\]](#page-77-3):

- I. Properties of the constituent phases *i.e. ceramic and polymer phase*
- II. Volume fraction and connectivity of the constituent phases

Apart from above mentioned dominant factors, the interfacial interaction between the ceramic particles and polymer matrix, percolation and porosity also have an influence of the final dielectric and piezoelectric properties of the composites. [\[57,](#page-77-2) [59\]](#page-77-4). Considering 0-3 composites, the geometry of the inclusions also affects the final properties of the composite [\[60\]](#page-77-5). Thus, many theoretical models were developed in order to predict the dependence of dielectric and piezoelectric coefficients of the composites as a function of volume fraction of filler particles, dielectric constant of constituent phases and interaction between the constituent phases.

In this chapter, a review on most widely used analytical models for predicting the dielectric and piezoelectric coefficients of 0-3 composites are presented. The five different analytical models selected – *Mixture Rule Models [\[61\]](#page-77-6) , Furukawa Model [\[62\]](#page-77-7) , Maxwell Wagner Model [\[63,](#page-77-8) [64\]](#page-77-9) , Jayasundere Model [\[65\]](#page-77-10) and Yamada Model [\[47\]](#page-76-2) –* were based on the works on dielectrics models for ceramic-polymer composites by *Araújo et al* [\[57\]](#page-77-2). The models discussed in this chapter were also used to compare and validate the experimental results, which will be explained later in Chapter 4.

#### **3.2 Mixture Rule Models**

Among the various reported mixture rule models, exponential mixture and logarithmic mixture are the most widely studied rules and thus will be further investigated in the following sections. The mixture rules are derived based on the assumption that the filler particles are uniformly distributed in a continuous matrix and no interactions between these constituents are taken into account [\[57,](#page-77-2) [61\]](#page-77-6).

#### **3.2.1 Exponential Mixture Rule**

Using above mentioned assumptions, the dielectric constant of composite containing dielectric fillers embedded in a polymer matrix can be expressed as:

$$
\left(\varepsilon_{c}\right)^{k} = V_{f}\left(\varepsilon_{f}\right)^{k} + \left(1 - V_{f}\right)\left(\varepsilon_{m}\right)^{k}
$$
\n(3.1)

where  $\varepsilon_c$ ,  $\varepsilon_f$  and  $\varepsilon_m$  are the dielectric constants of the composite, pure ceramic filler and polymer matrix respectively, *k* is an empirical parameter that depends on shape and orientation of the filler particles and *V<sub>f</sub>* is the volume fraction of the filler medium. In general, the value of *k* corresponds to -1 (series model) or 1 (parallel model), with the former being derived by considering the total capacitance (which is later on used to derive dielectric constant) of the composite as the sum of two capacitances in series connection whereas *k*=1 corresponds to parallel connection. In addition, a mixture model for randomly dispersed ceramic filler particles was also derived for which the value of *k c*orresponds to 1/3 and is termed as random model. Apart from above mentioned three exponential mixture models with constant *k* value, a modified empirical equation was proposed by Wakino for *k* (shown in Eq. 1.9) with an assumption based on non-aspect and random dispersion of filler particles in polymer matrix.

$$
k = V_f - 0.35\tag{3.2}
$$

The value of k for series and parallel model are two extreme cases (known as Wiener boundary values) and thus is expected to have poor accuracy when compared with that of experimental values. But in case of random model, the value of *k* = 1/3 is closer to the physical condition and thus provides a better accuracy than that of series and parallel models. The limitation of exponential mixture rule is that these set of mixture rules are compatible only with higher volume percentage of filler materials [\[61\]](#page-77-6).

#### **3.2.2 Logarithmic Mixture Rule**

Another important mixing rule is Lichtenecker's logarithmic mixing rule and is considered as the inverse of the exponential rules. The logarithmic rule follows the same assumptions as that of exponential mixture rules but the value of *k* is determined from the experimental data. Hence the Lichtenecker's rule is regarded as semi-empirical in nature and is given by the following equation [\[66,](#page-77-11) [67\]](#page-77-12):

$$
\log \varepsilon_c = V_f \log \varepsilon_f + (1 - V_f) \log \varepsilon_m \tag{3.3}
$$

The main drawback of Lichtenecker's rule is that it has been derived on the basis of fitting to the empirical data and lacks a physical model. In addition, the mixing rule can be applied only if  $\varepsilon_f$  differs slight from  $\varepsilon_m$ . In spite of these drawbacks, the logarithmic mixture rule has proven to be a useful formulation for the determination of the effectivity dielectric constant of composites [\[64,](#page-77-9) [68\]](#page-77-13).

#### **3.3 Furukawa Model**

Furukawa studied a two phase system composed of spherical inclusion (i.e. ceramic filler) embedded in a polymer matrix, which in turn is covered with a homogeneous medium whose properties approximate the average composite properties, as shown in Fig. 3.3. Using above mentioned conditions, Furukawa formulated following equations for the dielectric and piezoelectric coefficients of 0-3 composites [\[69\]](#page-77-14):

$$
\varepsilon_c = \frac{(1+2V_f)}{(1-V_f)} \varepsilon_m \tag{3.4}
$$

$$
(d_{33,c}) = \frac{15V_f}{(2+3V_f)(1-V_f)} \frac{\varepsilon_m}{\varepsilon_f} (d_{33,f})
$$
\n(3.5)

$$
(g_{33,c}) = \frac{15V_f}{(1+2V_f)(2+3V_f)}(g_{33,f})
$$
\n(3.6)

where  $V_f$  is the volume fraction of ceramic filler,  $d_{33}$  and  $g_{33}$  are the piezoelectric charge constant and voltage constants respectively and ε is the dielectric constant with the subscripts *f* and *m* corresponding to that of ceramic and polymer phase respectively ( $\varepsilon_f >> \varepsilon_m$ ). The main drawback of Furukawa model is that no interactions between the constituent phases are taken into consideration while formulating the equations since the model assumes that the composite is electrically homogeneous. But this may not be true in case of a two-phase composite system due to the space charge effects (i.e. Maxwell-Wagner effect)[\[70\]](#page-78-0).

### **3.4 Maxwell–Wagner Model**

Maxwell proposed a simple model for determining the effective dielectric constant of randomly distributed non-interacting particles in a polymer matrix, given by Eq. 1.14. The model assumes that the particles are well dispersed in the polymer matrix and the potential around each filler particle do not have any influence on surrounding particles as most of them are not touching each other. This assumption of Maxwell-Wagner model restricts its application to composites with low filler concentration. Another limitation of this model is that it is generally valid when the properties of the two phases in the composite are similar [\[71\]](#page-78-1). In spite of its drawbacks, Maxwell-Wagner model has been widely used for the calculation of the dielectric constant of filler-polymer composites [\[72\]](#page-78-2).

$$
\varepsilon_c = \varepsilon_m \frac{2\varepsilon_m + \varepsilon_f + 2V_f(\varepsilon_f - \varepsilon_m)}{2\varepsilon_m + \varepsilon_f - V_f(\varepsilon_f - \varepsilon_m)}
$$
(3.7)

#### **3.5 Jayasundere Model**

Jayasundere and Smith developed an analytical expression for effective dielectric constant ( $\varepsilon_c$ ) and piezoelectric charge coefficient ( $d_{33,c}$ ) (given by Eq. 1.15 and 1.16) for a 0-3 composite by considering a model which consists of piezoelectric particles randomly distributed in a dielectric medium and subjected to the condition  $\varepsilon_f >> \varepsilon_m$ , where  $\varepsilon_f$  and  $\varepsilon_m$  are the dielectric constants of the filler and the surrounding dielectric medium respectively. Unlike previously mentioned models, Jayasundere model takes into consideration of the electric field interactions between the filler particles, which are assumed to be spherical in shape [73].

$$
\mathcal{E}_{c} = \frac{V_{m}\varepsilon_{m} + V_{f}\varepsilon_{f}\left(\frac{3\varepsilon_{m}}{\varepsilon_{f} + 2\varepsilon_{m}}\right)\left(1 + \frac{3V_{f}(\varepsilon_{f} - \varepsilon_{m})}{\varepsilon_{f} + 2\varepsilon_{m}}\right)}{V_{m} + V_{f}\left(\frac{3\varepsilon_{m}}{\varepsilon_{f} + 2\varepsilon_{m}}\right)\left(1 + \frac{3V_{f}(\varepsilon_{f} - \varepsilon_{m})}{\varepsilon_{f} + 2\varepsilon_{m}}\right)}
$$
(3.8)

$$
(d_{33,c}) \approx (d_{33,f}) \frac{\varepsilon_c}{\varepsilon_f} \left( 1 + \frac{3V_f \varepsilon_f}{2\varepsilon_m + \varepsilon_f} \right)
$$
(3.9)

The Jayasundere model is not applicable for 0-3 composite with high volume fractions of ceramic fillers (*V<sup>c</sup>* > 0.70) because of the presence of some 1-3 connectivity associated with the ceramic phase [\[73\]](#page-78-3).

#### **3.6 Yamada Model**

Yamada studied the binary system consisting of PZT powder embedded in a PVDF polymer matrix and proposed a model to explain the behaviour of the properties of the composite using the properties of its constituent materials. The model consists of ellipsoidal particles dispersed in a continuous polymer medium, as shown in Fig. 3.6, and the permittivity  $(\epsilon_c)$  and piezoelectric charge coefficient (d<sub>33,c</sub>) of the composite was given as follows [\[47,](#page-76-2) [58\]](#page-77-3):



**Fig. 3.1: Binary system consisting of piezoelectric ellipsoidal particles dispersed in a continuous medium (adapted from [\[58\]](#page-77-3)).**

$$
\varepsilon_c = \varepsilon_m \left( 1 + \frac{nV_f(\varepsilon_f - \varepsilon_m)}{n\varepsilon_m + (\varepsilon_f - \varepsilon_m)(1 - V_f)} \right) \tag{3.10}
$$

$$
(d_{33,c}) = \frac{V_f \varphi n \varepsilon_c (d_{33,f})}{n \varepsilon_c + \varepsilon_f - \varepsilon_c}
$$
\n(3.11)

where *n* is the shape factor (depends on the geometry of the filler particles and its orientation with respect to the surface of the composite),  $\varphi$  is the ceramic poling ratio,  $V_f$  is the volume fraction of the filler particles and ε is the dielectric constant with the subscripts *c, f* and *m*  corresponding to the properties of composite, ceramic filler and polymer matrix.

A prediction of dielectric constant for 0-3 PZT-Epoxy composite for varying PZT volume fractions is shown in Fig 3.2. The dielectric constant of the polymer matrix was measured as  $\varepsilon_m$ =4.2 and the dielectric constant of the PZT ceramic filler particles were  $\varepsilon_f$  = 1085 (MPB composition was taken as an example). Among these analytical models, the Series and Parallel models act as the lower and upper boundary for the values of dielectric constant of composites between 0-3 and 1-3 composites respectively and all the predicted as well as the experimentally determined values of dielectric constant of composites reported till date lies within these two boundaries. All the models studied in this chapter have several parameters in common such as dielectric constant of the ceramic and polymer phase,  $d_{33}$  of ceramic fillers and volume fraction of the ceramic fillers. Apart from these, Yamada Model takes into consideration of the shape factor of the filler particles and poling ratio of the composites while predicting the dielectric and piezoelectric properties of the composites. Another important model to be considered is the Maxwell-Wagner model. This model is derived by taking into consideration of the depolarization effect caused due to the presence of two dielectric mediums (ceramic and polymer) in a system. Hence, Yamada and Maxwell-Wagner are among the most widely used analytical models, to predict the dielectric and piezoelectric properties of composites. However, the actual dielectric and piezoelectric properties of the 0-3 composite depend on many other parameters, including the degree of interaction between the filler and the matrix, homogeneity of the ceramic particle dispersion in the matrix and the precise connectivity of the filler particles at high volume fractions.



**Fig. 3.2: Analytical model predictions for dielectric constant of composite as a function of vol. fraction of ceramic filler**

# **4. Results and Discussions**

This section discusses the experimental data, its interpretation and comparison with the analytical models. The results of the microstructural analysis are presented from Section 4.1, followed by the P-E Hysteresis measurement in Section 4.2. Finally the outcome of the experimental measurement of dielectric and piezoelectric properties of ceramics and composites are presented and compared with that of the analytical models in Section 4.3.

## **4.1 Phase Analysis and Microstructure Characterization**



#### **4.1.1 X-ray Diffraction (XRD)**

**Fig. 4.1: X-ray diffraction pattern of calcined PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic powder** 



**Fig. 4.2: X-Ray Diffraction of calcined ceramic powder exhibiting single phase formation: (a) PZT-20 and (b) PZT-60**

The room temperature X-ray diffraction patterns of Nb-doped PbNb $_{0.01}[Zr_xTi_{(1-x)}]O_3$  as a function of Zr composition are shown in Fig. 4.1. The sharp and well defined single phase diffraction peaks confirms the formation of perovskite structure in all PZT ceramic powder compositions. The phases were identified by the analysis of the XRD patterns within the two theta (2θ) range from 20° to 60°. Within this range, (100), (110), (111) and (200) crystallographic planes experienced a shift in their 2θ position with varying Zr/Ti ratio. This systematic shift in the position of 2θ with respect to Zr composiion ratio indicates the transformation from rhombohedral (PZT-80) to tetragonal phase. The splitting of (002) reflection into (002) and (200) reflections at PZT-52 (MPB i.e. x=0.52) indicates the presence of morphotropic phase boundary (MPB) region, at which the co-existence of the tetragonal and rhombohedral phases are observed. The reason behind this splitting of reflections at MPB region can be attributed to the compositional fluctuations, leading to the coexistence of the rhombohedral and tetragonal phases [\[74-76\]](#page-78-4). It can also be seen that when Zr/Ti < 52/48, the diffractograms exhibit distinct split peaks at (101) and (110), which denotes the tetragonal phase composition of the ceramic powder. In addition, with the increase in the tetragonal phase, the (111) peak becomes more distinct. Thus, from the diffraction pattern it can be seen that all the compositions were of pure perovskite structure and observed the rhombohedral to tetragonal phase transformation of PZT ceramic powder as the Zr composition decreases. Fig 4.2 shows the full sized diffraction pattern of PZT-20 and PZT-60 compositions in order to highlight phase purity and single phase formation.



#### **4.1.2 Lattice Parameter**

**Fig. 4.3: Lattice parameters and** *c/a* **ratio of calcined PbNb0.01[ZrxTi(1-x)]O3 ceramic powder**

Fig. 4.3 shows the variation of lattice constants `*a*' and `*c*' and *c/a* ratio as a function of the Zr mole%. The *c/*a ratio for MPB composition of PZT was found to be 1.025 whereas that of PbTiO<sub>3</sub> was 1.062. Even though the lattice constant 'c' remains almost constant, an increase in lattice constant '*a*' is observed, thereby leading to a reduction in *c/a* ratio with increase in Zr content. This reduction in c/a ratio indicates that the tetragonality of PZT ceramics decreases with increase in Zr content and these values of the lattice parameters were found to be close to ones which were reported previously [\[77\]](#page-78-5).

#### **4.1.3 Particle Size Analysis**

The particle size distribution of the calcined  $PbNb<sub>0.01</sub>[Zr<sub>x</sub>Ti<sub>(1-x]</sub>]O<sub>3</sub>$  ceramic powders, for *x* = 0 to 0.8, were measured using laser diffractometry. Since the particle size of the ceramic filler have an influence on the dielectric and piezoelectric properties of the 0-3 PZT-Epoxy composites prepared [\[78\]](#page-78-6), it was necessary to ensure that the there was no major differences between the particle size distribution and mean particle size of all the compositions of ceramic powders prepared. Table 4.1 shows the influence of Zr content on the particle size distribution (D10, D50 and D90) of the ceramic powder compositions. The standard deviation of the particle size was estimated to be 1.25 µm. Even though there is slight variation in the particle size distribution and mean particle size, the difference is not significant enough to have any influence on the dielectric and piezoelectric properties of the 0-3 PZT-Epoxy composites [\[79,](#page-78-7) [80\]](#page-78-8).





#### **4.1.4 Scanning Electron Microscopy (SEM)**

The particle size and morphology of the PbNb $_{0.01}[Zr_xTi_{(1-x)}]O_3$  ceramic powders were analysed using scanning electron microscopy (SEM). Fig. 4.4 (a-c) shows the SEM micrographs of the calcined ceramic powder with Zr mole% corresponding to 0 (tetragonal), 0.52 (MPB) and 0.80 (rhombohedral) respectively. The particle size of the calcined powder was found to increase with Zr content, which was well supported by the results from particle size analysis of the ceramic powders compositions. The calcined PT powder appears to have spherical morphology whereas the other ceramic compositions possess polyhedral morphology.





**Fig. 4.4: Microstructure of ceramic powder for compositions corresponding to (a) PT, (b) MPB and (c) PZT-80 (i.e.** *x* **= 0.80)**

Fig 4.5 (a-d) shows the SEM micrographs of ceramic disks sintered at 1250°C for Zr mole% corresponding to 0 (PT), 0.52 (MPB) and 0.80 respectively. It can be seen that the MPB and rhombohedral composition densely packed microstructure whereas PT has a porous microstructure, which shows the poor sinterability of tetragonal PZT ceramics. The reason behind poor sinterability of PT ceramics is due to the large spontaneous strain and thermal expansion anisotropy of the tetragonal phase of lead titanate, which results in the mechanical fracture of the lead titanate ceramics (see Fig. 4.5(d)) as they are cooled from sintering temperature through the cubic to the tetragonal phase transition at 490°C [\[81\]](#page-78-9). In addition, the formation of pyrochlore phase is clearly observed in case of rhombohedral composition, which became less conspicuous with increasing Ti content in the ceramic powder compositions. The presence of non-ferroelectric pyrochlore phase will have a detrimental effect on the piezoelectric properties of the ceramics and thus need to be avoided [\[82\]](#page-78-10). But this formation of pyrochlore phase was not observed in case of calcined ceramic powder due to the two-stage calcination process followed (i.e. low temperature and high temperature calcination) [\[83\]](#page-78-11).



**Fig. 4.5: Microstructure of ceramic disks sintered at 1250°C for compositions corresponding to (a) PT, (b) MPB, (c) PZT-80 (i.e. x = 0.80) and (d) crack on surface of PT ceramics after sintering process**

The SEM micrographs were also used to analyse the dispersion of ceramic particles in the composites prepared. Fig. 4.6 shows the SEM micrographs of the cross-section of 0-3 PZT-

Epoxy Composites for 20 and 40 vol% of ceramic filler of PT and MPB composition. It can be seen that for 20 vol% composite, the system looks dilute with minimum particle to particle connectivity. On the other hand, in case of 40 vol% composite, a better particle to particle connectivity is observed, which results in higher piezoelectric properties with increasing volume percent of ceramic filler, as reported in prior works [\[41,](#page-76-3) [70\]](#page-78-0).



**Fig. 4.6: Cross-sectional micrographs of composites prepared with 20 vol% (a) and 40 vol% (b) of PbNb**<sub>0.01</sub> $[Zr_xTi_{(1-x)}]O_3$  ceramic powder with x = 0.52 (MPB)

## **4.2 Dielectric and Piezoelectric Properties**



**Table 4.2: Density of the sintered PbNb0.01(ZrxTi(1-x))O3 ceramics for x ranging from 0 to 0.80** 

Table 4.2 shows the densities of the sintered PbNb<sub>0.01</sub>(Zr<sub>x</sub>Ti<sub>(1-x)</sub>)O<sub>3</sub> measured using the Archimedes method. The densities of the sintered ceramics are in the range of 7.12g/cm<sup>3</sup> to 7.49g/cm<sup>3</sup> (90-93 % of theoretical density) and are dependent on Zr composition. From the density values, it is evident that all the ceramic specimens prepared are eligible for electrical characterization.

#### **4.2.1 Ceramics**

Fig. 4.7 shows the electric-field induced polarization hysteresis of PbNb $_{0.01}(Zr_xTi_{(1-x}))O_3$ ceramics, for x = 0, 0.52 (MPB) and 0.80, measured at an applied field ranging from 4.5 to 7.5 kV/mm and at room temperature. The hysteresis loop clearly shows that all the loops fully opened up and had attained polarisation saturation. The hysteresis measurement displays significantly higher remnant polarization  $(P_r)$  of MPB compositions than that of its tetragonal and rhombohedral compositions. The  $P_r$  increases with increasing Zr content upto MPB composition  $(x = 0.52)$  and then decreases. This behaviour is due the ferroelectric characteristics reaching its optimized values at MPB. However the decrease in  $P_r$  of PZT-80 composition is caused due to the Zr-rich rhombohedral phase in its composition [\[84\]](#page-78-12).



**Fig. 4.7: P-E Hysteresis loop for PbNb**<sub>0.01</sub> $(Zr_xTi_{(1-x)})O_3$  ceramics for  $x = 0$ , 0.52 (MPB) and 0.80



**Fig. 4.8: The electric-field induced strain curves of PbNb0.01(ZrxTi(1-x))O<sup>3</sup> ceramics, for x = 0, 0.52 (MPB) and 0.80**

Fig. 4.8 shows the electric-field induced strain curves of PbNb<sub>0.01</sub>(Zr<sub>x</sub>Ti<sub>(1-x)</sub>)O<sub>3</sub> ceramics, for  $x = 0$ , 0.52 (MPB) and 0.80, measured at a frequency of 1 kHz and at room temperature. It can be seen that each sample exhibits the classical butterfly shaped strain loops irrespective of their Zr composition. The well-defined strain loop of PT and MPB ceramics suggests that these ceramics possess excellent actuation properties compared to that of rhombohedral PZT ceramics. In general, the electric-field-induced strain in ceramics is caused by the complicated domain switching, piezoelectricity, electrostriction, and electric field. In other words, the strain value is dependent on the domain switching, piezoelectric constant, polarization, and applied electric field. As a result, MPB composition displays the maximum strain in ceramics due to the coexistence of rhombohedral and tetragonal phases at MPB, which in turn leads to enhanced polarization and piezoelectric properties [\[85\]](#page-78-13).

Fig. 4.9 and 4.10 shows the variation of dielectric constant and piezoelectric charge constant of ceramics respectively, as a function of Zr composition. Since it is difficult to perform the poling process of tetragonal PZT ceramic, including PT, the piezoelectric charge constant  $(d_{33})$  of the ceramics were determined by substituting the experimental values of the dielectric constant of corresponding composites in Eq. 1.18 from Yamada's model (See Fig. 4.9). The reason behind this difficulty in the poling process for tetragonal ceramic disks is due of the large coercive field of these ceramics [\[81\]](#page-78-9). In addition to this, as mentioned in Section 2.2, it was difficult to perform a complete sintering process of the tetragonal ceramics due to its large lattice anisotropy (*c/*a ratio for PT is 1.062) and high vapour pressure, thereby resulting in a fragile and porous ceramic disks .



**Fig. 4.9: Variation of room temperature dielectric constant (εr) of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> as a function of Zr mole%**



**Fig. 4.10: Variation of room temperature piezoelectric charge constant (d33) of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramics as a function of Zr mole%**

Similar to dielectric constant, the maxima of the piezoelectric charge constant was also observed at MPB composition (See Fig. 4.10). The reason for this sharp increase in the dielectric and piezoelectric properties is attributed to the presence of 14 polarization directions, originating from the co-existence of tetragonal and rhombohedral phases at MPB, which are equivalent or nearly equivalent in free energy. This corresponds to highly polarizable state at MPB, which in turn favours strong dielectric and piezoelectric effects [\[5,](#page-74-1) [86,](#page-79-0) [87\]](#page-79-1). As mentioned previously, when  $x > 0.52$ , the composition has only rhombohedral phase whereas when x < 0.52, the composition is dominated by tetragonal phase. In either case, the number of domain variants is less than that of MPB composition, which in turn inhibits the piezoelectric response of the ceramics. In addition, the porous nature of tetragonal ceramic disks also contributed towards the decrease in piezoelectric charge constant since the presence of pores reduces the polarization per unit volume [\[5,](#page-74-1) [88\]](#page-79-2), which in turn reduces  $d_{33}$ .

#### **4.2.2 Composites**

The electric-field dependence of polarization studies for 0-3 composites were carried out for different applied fields (5 – 40 kV/mm) at room temperature and the loops are shown in Fig. 4.11. The development of hysteresis loop confirms the ferroelectric nature of the 0-3 PZT-Epoxy composites prepared. With the increase in the electric field, the composites exhibited higher polarization due to the alignment of the dipoles within the material, resulting in an increase in the area of the P-E loops. However, the remnant polarization  $(P_r)$  is much lower than that of bulk ceramics due to the influence of the non-ferroelectric polymer phase. It can also be seen that the poling efficiency of composites with 40 vol% of ceramic filler is much higher than

that of the ones with 20 vol%. This is due to the better connectivity of the ceramic filler particles in the composites with 40 vol% of ceramic filler.



**Fig. 4.11: Polarization hysteresis loop for (a) 20 vol% and (b) 40 vol% of 0-3 PZT (MPB)-Epoxy Composite**



**Fig. 4.12: Dielectric Constant (εr) as a function of Zr mole% in 0-3 Composites with 20 and 40 vol% of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic filler**

Fig. 4.12 shows the variation of dielectric constant of 0-3 PZT-Epoxy composites as a function of Zr composition. Compared to that of bulk ceramics (Fig. 4.8), the lower dielectric constant observed in composites is due to the presence of passive polymer phase surrounding the active ceramic phase within the 0-3 PZT-Epoxy composite. It is also noteworthy that even though there is a large difference between dielectric constant of PT and MPB ceramics, when

these ceramics compositions are used as a filler material in composites, the effective dielectric constant of the composite do not exhibit such a significant difference. Another major observation is the relatively lower difference between the dielectric constants of PT and MPB composites compared to that of its corresponding bulk ceramics. From Fig. 4.9, it can be seen that the difference between the dielectric constant of PT and MPB ceramic disks is about 885 whereas in case of 0-3 composites, this difference has drastically reduced and both the composites possess about same dielectric constant. As a result, it could be seen that even after the addition of ceramic fillers with a wide range of dielectric constant, the resultant dielectric constant of the composites remains within smaller range. The reason behind this anomaly between bulk ceramics and composites is related to the difference in the dielectric constant of each constituent (i.e. PZT ceramic filler and epoxy matrix) [\[89\]](#page-79-3). Considering 0-3 composite, which contains ceramic powder with MPB composition as filler, the difference in the dielectric constant of epoxy matrix ( $\varepsilon$ <sub>r, epoxy</sub> = 4.2) and the ceramic filler ( $\varepsilon$ <sub>r, filler</sub> = 1085) is about 1081. Alternatively, in case of PT ceramic filler ( $\varepsilon_{r, \text{ filter}}$  = 200), the difference is only 196. This lower difference between the dielectric constant of the polymer and ceramic phase has resulted in a better homogenization between the PT ceramic filler and epoxy matrix in 0-3 composites and thus had resulted in a dielectric constant, which is comparable to that of MPB composites. This observation is well supported by the results obtained by the experimental analysis and analytical models as shown in Fig. 4.13 and 4.14. It is clearly evident that, in all analytical models, the dielectric constant of composites attains saturation after a sharp increase with the dielectric constant of constituent ceramic fillers in the initial stage. Once saturated, the increase in the dielectric constant of ceramic filler particles does not have any significant impact on the dielectric constant of its composites. This observation is consistent with the experimental results also.



**Fig. 4.13: Variation of dielectric constant of 0-3 composite (20 vol%) as a function of the dielectric constant of corresponding PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic compositions - Experiemental v/s Analytical**



**Fig. 4.14: Variation of dielectric constant of 0-3 composite (40 vol%) as a function of the dielectric constant of corresponding PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic disks - Experiemental v/s Analytical**

Fig. 4.15 shows the variation of piezoelectric charge constant ( $d_{33}$ ) as a function of Zr mole% for 0-3 PZT-Epoxy composites. As evidenced by prior works [30, 40], composites with 40 vol% of ceramic filler show higher  $d_{33}$  than those with 20 vol% of filler due to the presence of higher content of active ceramic phase and better connectivity between the ceramic filler particles. Similar to that of bulk PZT ceramics reported by Jaffe, an increase in the d33 of composites is observed, with the increasing Zr content, for compositions close to MPB (i.e. from x=0.5), attaining its maxima at x=0.52 (i.e. MPB composition). This is due to the higher poling efficiency of the PZT ceramics at MPB composition. . On further addition of Zr content (i.e. x > 0.52), the antiferroelectric rhombohedral phase dominates, resulting a sharp decline in the d33 of ceramic filler and consequently its composites. Another striking feature observed is the relatively higher d<sub>33</sub> of 0-3 composites with PT ( $x = 0$ ) ceramic fillers compared to that of the one with MPB (*x* = 0.52) ceramic filler. Fig. 4.16 and 4.17 shows the results of the analytical models used to predict the  $d_{33}$  of composites (20 and 40 vol% of ceramic fillers respectively) as a function of  $\varepsilon_r$  of ceramic fillers used. Similar to the observation made in case of effective dielectric constant of composites, the  $d_{33}$  of the composites also attained saturation after a sharp increase with the dielectric constant of constituent ceramic fillers in the initial stage. Once saturated, the increase in the dielectric constant of ceramic filler particles does not have any significant impact on the dielectric constant of its composites. The phenomenon which is responsible for this observation is known as the depolarization effect (shown in Fig. 4.20), which will be discussed in detail in Section 4.5.



**Fig. 4.15: Variation of room temperature piezoelectric charge coefficient (d33) of 0-3 Composites for 20 and 40 vol% of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic filler**



**Fig. 4.16: Variation of room temperature piezoelectric charge constant (d33) of 0-3 Composites for 20 vol% of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic filler**



**Fig. 4.17: Variation of room temperature piezoelectric charge constant (d33) of 0-3 Composites for 40 vol% of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic filler**

## **4.3 Voltage Sensitivity**

#### **4.3.1 Ceramics**



**Fig. 4.18: Variation of room temperature piezoelectric voltage coefficient (g33) of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramics**

The piezoelectric voltage coefficient ( $g_{33}$ ), shown in Fig. 4.18 was calculated using Eq. 1.6, which was presented in Section 1.4.3. It can be seen that the highest  $g_{33}$  is exhibited by PbTiO<sub>3</sub> (PT) ceramics, in spite of its lower  $d_{33}$  than that of MPB ceramics. The reason behind this anomaly is the significantly lower dielectric constant of PT ( $\varepsilon_r$  = 194) compared to that of MPB ceramics ( $\varepsilon_r$  = 1085). It is noteworthy that the piezoelectric voltage coefficients ( $g_{33}$ ) increases towards the tetragonal field while it remains almost constant in the rhombohedral field until the antiferroelectric nature of the rhombohedral phase gains over the ferroelectric properties, after which the  $g_{33}$  drops down significantly.

#### **4.3.2 Composites**

The piezoelectric voltage constant  $(g_{33})$  as a function of Zr composition is shown in Fig. 4.19. Similar to that of ceramics, the  $g_{33}$  values of the composites were also obtained using the Eq. 1.6 and it ranges from 11 to 42 mV.m/N, depending upon the vol% of ceramic filler and Zr mole%. The highest value of 42 mV.m/N for composite with 40 vol% of PT ceramic filler was found to be comparable with the values reported previously [\[90\]](#page-79-4). The reason behind the highest voltage sensitivity of PT composites can be attributed to the moderately high  $d_{33}$  and relatively lower dielectric constant of 0-3 PT-Epoxy composites compared to that of its MPB counterpart (see Fig 4.12 and 4.15). This high  $g_{33}$  value makes the 0-3 PT-Epoxy composite a very attractive material for sensory applications.



**Fig. 4.19: Variation of room temperature piezoelectric voltage coefficient (g33) of 0-3 Composites for 20 and 40 vol% of PbNb0.01[ZrxTi(1-x)]O<sup>3</sup> ceramic filler** 

## **4.4 Comparison of Dielectric and Piezoelectric Properties – Sintered ceramics and composites**

As mentioned in earlier sections, most of the prior works on piezoelectric materials involves the application of MPB or close to MPB compositions of PZT ceramics due to the enhanced dielectric and piezoelectric properties observed at MPB. This is also evident from Fig. 1.8 – 1.10, reported by Jaffe et al. Since the current work explored the entire range of PZT phase diagrams and systematically studied the dielectric and piezoelectric properties of ceramic compositions corresponding to PbNb<sub>0.01</sub>(Zr<sub>x</sub>Ti<sub>(1-x)</sub>)O<sub>3</sub>, ranging from pure tetragonal (x = 0) to rhombohedral ( $x = 0.80$ ) ceramics. The dielectric and piezoelectric properties of sintered ceramics prepared from these compositions, shown in Fig 4.8 and 4.9, clearly displays the highest piezoelectric and dielectric properties at of MPB compositions. As far as voltage sensitivity of the sintered ceramics are considered, it can be seen that PT and MPB based ceramics have comparable  $g_{33}$  but the poor sinterability and poling difficulties associated with PT ceramics restricted its application in piezo devices.

In case of composites, in spite of having observed a significant increase in the  $\varepsilon_r$  and  $g_{33}$ of MPB based composites, shown in Fig. 4.12 and 4.15, the difference between the dielectric and piezoelectric properties of MPB and non-MPB based composites were not as significant as their sintered ceramics as shown in Fig. 4.9 and 4.10. Due to this unique combination of lower dielectric constant and moderately higher  $d_{33}$ , composites with PT ceramic fillers exhibited a higher  $g_{33}$  than that of its MPB and close to MPB counterparts (see Fig. 4.19). In addition, the poor sinterability associated with sintered ceramics was not an area of concern in case of composites, since the composites made of calcined ceramic filler particles. As a result, the PT based composite materials can be considered as an excellent candidate towards piezoelectric sensor devices.

#### **4.5 Depolarization Field**

When a dielectric material, such as the ceramic filler, is polarized under an applied electric field, surface charges appears along the boundaries of each of the ceramic particles embedded in the polymer matrix (shown in Fig. 4.20). The formation of these surface charges results in the production of a depolarization field  $(E_D)$  that acts opposite to the applied electric field  $(E_0)$ . As a result, the net polarization within the caramic particle gets deteriorated while the field outside remains the same [\[91\]](#page-79-5). In addition, the magnitude of depolarization field increases with increasing dielectric constant of the particle. Hence, by comparing the above mentioned relation between deplorization field and dielectric constant of ceramics (Fig. 4.9), it can be concluded that the increase in the  $d_{33}$  in 0-3 composites with decreasing Zr content is due to the

corresponding decrease in the dielectric constant of the ceramics. This has resulted in higher  $d_{33}$  for PT composites compared to that of its MPB counterpart. Eq. 4.1 and 4.2 shows the expression for depolarization factor ( $\alpha$ ) and effective dielectric constant of composites ( $\varepsilon_c$ ) respectively. The model consists of a filler material with dielectric constant  $\varepsilon_f$  (i.e. ceramics) embedded as spheres in a matrix with dielectric constant  $\varepsilon_f$  (i.e. polymer). The parameter V corresponds to the total volume of filler material in a sphere and is given by  $V = V_f/N$ , where  $V_f$ is the volume fraction of filler material and N is interpreted as the number of spheres per unit volume.



**Fig. 4.20: Depolarization Effect [\[91\]](#page-79-5)**

$$
\alpha = \frac{3\varepsilon_m(\varepsilon_f - \varepsilon_m)}{(\varepsilon_f + 2\varepsilon_m)}V
$$
\n(4.1)

$$
\varepsilon_c = \varepsilon_m \left( \frac{1 + \frac{2N\alpha}{3\varepsilon_m}}{1 - \frac{N\alpha}{3\varepsilon_m}} \right)
$$
(4.2)



**Fig. 4.21: Depolarization factor as a function of dielectric constant of the ceramic inclusions for different N values**

Fig. 4.21 shows depolarization factor as a function of dielectric constant of the ceramic inclusions for different N values. The value of N corresponds to the number of particles within the polymer medium. It could be seen that the depolarization factor increases with increasing  $\varepsilon_r$ of the ceramic filler and this dependence is the driving force behind the observed trend in the experimentally determined  $\varepsilon_r$  and d<sub>33</sub> of composites. In addition to this, it could also be seen that the effect of depolarization factor got drastically reduced with increase in number of particles. The reason behind this significant reduction can be attributed towards the better connectivity between the ceramic filler particles with increase in N value

#### **4.6 Polarization Fatigue**

The effect of electric field on the remnanat polarization of PT and MPB composites over a period of  $10^5$  cycles at room temperature are shown in Fig 4.22. It is observed that the MPB composites undergoes a wide range of variation in its polarization during the the electric cycles where as in case of PT composites, the electric field have relatively less impact on polarization. This decrease in polarization of MPB composites will have a detrimental effect on the sensorial properties of the composites. It is most likely that such a drop in polariation and thereby sensorial properties, is caused by the delamination between PZT filler particles and the polymer matrix since no intrinsic changes in the properties of the constituent ceramic and polymer phases are to be expected at room temperature. Thus, 0-3 composites with PT ceramic filler exhibits greater resistance to electric fatigue that its MPB counterpart over a longe range of electric cycles.



**Fig. 4.22: Polarization fatigue of 0-3 composites with 40 vol% of PT and MPB based ceramic filler**

## **5. Conclusions and Recommendations**

## **5.1 Conclusions**

In the present work, the whole range of PZT compositions, having the general formula  $PbNb<sub>0.01</sub>(Zr<sub>x</sub>Ti<sub>(1-x)</sub>)O<sub>3</sub>$  (for x=0 to 0.8), and its corresponding sintered ceramics and composites were prepared and studied. The PZT compositions were prepared by means of conventional mixed oxide methods, during which a two-stage calcination process was adopted in order to obtain pure perovskite structure. The formation of the perovskite structure and phase transformation, due to varying Zr/Ti ratio, was confirmed using X-ray Diffraction (XRD) analysis of the ceramic powders prepared. The XRD results revealed the co-existence of rhombohedral and tetragonal phases at Zr/Ti ratio of 52/48 (MPB). The XRD results were also used to determine the lattice parameters of the ceramic powder compositions, which further confirmed the phase transformation from rhombohedral to tetragonal with decreasing Zr/Ti ratio. The microstructure and particle size distribution of the ceramic particles were analysed using scanning electron microscope (SEM) and laser diffractometry respectively. The laser diffractometry results confirmed that the particle size distribution of the ceramic powders prepared were within  $2 - 3 \mu m$ . The calcined PZT powder compositions were sintered and pressed into ceramic disks and was also used as ceramic filler materials to prepare 0-3 piezoelectric composites. The piezoelectric behaviour of the sintered ceramics and 0-3 composites were studied using polarization hysteresis (P-E) and strain loop measurement. The effect of Zr/Ti ratio on the dielectric and piezoelectric properties of both MPB and non-MPB compositions in ceramics and composites were studied. Finally, the influence of electric fatigue on the polarization of the PbTiO<sub>3</sub> (PT) and morphotropic phase boundary (MPB) based composites were analysed.

The P-E measurement of sintered ceramics showed saturated loops with remnant polarization ranging from 4 to 28  $\mu$ C/cm<sup>2</sup> depending upon the Zr composition. On the other hand, the P-E hysteresis measurement of 0-3 composites exhibited unsaturated and closed loops even at a very high applied field. This is due to the presence of polymer phase, which obscures a major part of the applied electric field. The dielectric and piezoelectric properties of the sintered ceramics and composites were measured and validated using several existing analytical models. The results of dielectric measurement showed that even though there is a large difference between the dielectric constant ( $\varepsilon_r$ ) of PT and MPB based ceramics, when these ceramic compositions are used as fillers in composites, the effective  $\varepsilon_r$  of the composites does not exhibit such a significant difference. The reason behind this anomaly is attributed towards the non-homogeneity between the dielectric constant of the ceramic filler particles and polymer matrix. This non-homogeneity, results in the formation of an electric field within the ceramic filler particle, which tends to oppose the applied electric field. This phenomenon, known as depolarization effect, comes into play due to the dispersion of highly dielectric PZT ceramic fillers ( $\varepsilon_r$  = 1080) particles in a lower dielectric epoxy matrix ( $\varepsilon_r$  = 4.8). The extent of depolarization field is directly proportional to  $\varepsilon_r$  of the ceramic filler and thus higher the  $\varepsilon_r$  of the ceramic filler, higher will be the depolarization field, which in turn has a detrimental effect on the effective  $\varepsilon_r$  of the composite. Since both, dielectric and piezoelectric charge constants  $(d_{33})$  are the measure of polarizability of a piezoelectric materials, the same depolarization effect is the reason behind the relatively higher effective  $d_{33}$  of PT composites. This lower  $\varepsilon_r$ combined with relatively higher  $d_{33}$  had led to a reasonably higher piezoelectric voltage coefficient  $(g_{33})$  in PT composites compared to that of MPB composites.

As a result, this combination of low dielectric constant and moderately high piezoelectric charge constant  $(d_{33})$  characterizes the 0-3 PT-Epoxy composites as excellent materials for voltage sensitivity. Hence, in a nutshell, this entire research work successfully explored the possibility of using non-MPB ceramic compositions in 0-3 composites for sensoric applications.

#### **5.2 Recommendations**

A knowledge base of dielectric and piezoelectric properties of 0-3 PZT-Epoxy composites based on the entire PZT phase diagram and ceramic filler material selection criteria has been established and documented in this research work. The findings of this research work will serve as a basis for further research into non-MPB based piezoelectric ceramic – polymer composites and a detailed research must be conducted for a thorough understanding on material and processing properties in order to optimize the dielectric and piezoelectric properties of the composite. Considering the outcome of the current research, following recommendations can be formulated for further research on this topic.

I. Lead free replacement of PZT powder:

Due to the health hazards posed by lead, the PZT ceramic powder can be replaced with lead-free ceramics materials such as BaTiO<sub>3</sub>, KNN and BNT-BT. This replacement will result in the fabrication of environmental friendly piezoelectric-polymer sensory composites.
II. Improved composite manufacturing techniques:

Apart from tape-casting, the piezoelectric composites could also be prepared through various other techniques such as by hot press and solvent casting. This would enable to compare the difference in the dispersion of ceramic filler particles and density of the composites, which in turn would have an impact on the dielectric and piezoelectric properties of the final composite. In addition, 0-3 piezoelectric composites can be by the process of dielectrophoresis (DEP), which has already been proved as a reliable technique to enhance the dielectric and piezoelectric properties of the 0-3 piezoelectric composites by converting them to quasi 1-3 composites. The same DEP can be used in case of non-MPB based composites, especially PT composites, in order to further enhance their  $\varepsilon_r$  and d<sub>33</sub> and thereby resulting in a higher  $g_{33}$  or voltage sensitivity.

III. Influence of different matrix types:

The effect of a different matrix type on the dielectric and piezoelectric properties of the composite could be studied further since matrices with higher  $\varepsilon_r$  could have a great influence on the properties of the composite. The increase in piezoelectric properties could even lead to the development of good piezoelectric composites sensors with lower volume percent ceramic fillers, which in turn results in more flexible composites.

IV. Potential applications in the field of aerospace engineering:

Since the non-MPB based composites has been proved to have higher voltage sensitivity, further works could be initiated in stretching out the potential applications of these composites in smart materials and structures for energy harvesting, structural health monitoring and vibrational dampeners.

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